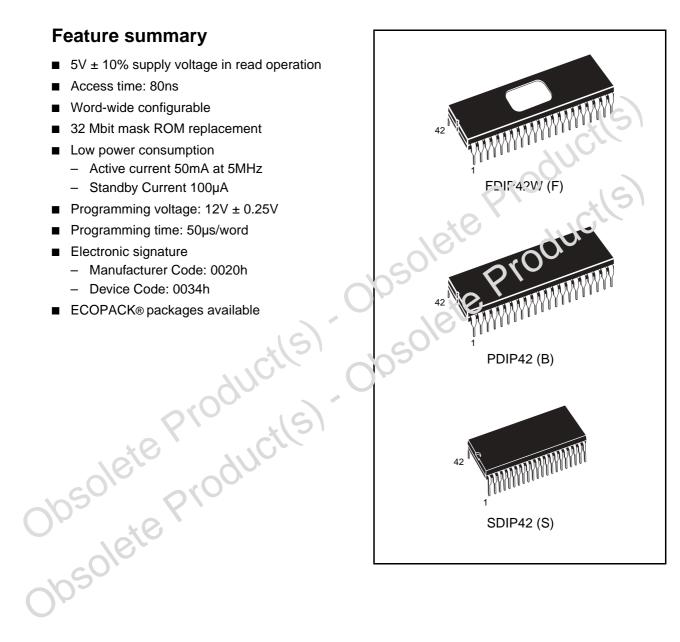


## 32 Mbit (2Mb x16) UV EPROM and OTP EPROM

#### Feature summary

- 5V ± 10% supply voltage in read operation
- Access time: 80ns
- Word-wide configurable
- 32 Mbit mask ROM replacement
- Low power consumption
  - Active current 50mA at 5MHz
  - Standby Current 100µA
- Programming voltage: 12V ± 0.25V
- Programming time: 50µs/word
- Electronic signature
  - Manufacturer Code: 0020h
  - Device Code: 0034h



Contents M27C322

# **Contents**

1	Summary description	5
2	Device operation	7
	2.1 Read mode	7
	2.2 Standby mode	7
	2.3 Two line output control	7
	2.4 System Considerations	8
	2.5 Programming	8
	2.6 PRESTO III Programming Algorithm	8
	2.7 Program Inhibit	9
	2.8 Program Verify	9
	2.9 Electronic Signature	0
	2.10 Erasure operation (applies to UV FFROM)	0
3	Maximum rating	2
4	DC and AC parameters	3
5	Package mechanical19	9
6	Part numbering	2
7000	Revision history	3
0050	ete '	
Opse		

M27C322 List of tables

## List of tables

Table 1. Table 2.	Signal Names	
Table 2.	Electronic Signature	
Table 4.	Absolute Maximum Ratings	
Table 5.	AC Measurement Conditions	
Table 6.	Capacitance (T <sub>A</sub> = 25 °C, f = 1 MHz)	14
Table 7.	Read Mode DC Characteristics	
Table 8.	Programming Mode DC Characteristics	
Table 9.	Read Mode AC Characteristics	16
Table 10. Table 11.	MARGIN MODE AC Characteristics	17 18
Table 11.	FDIP42W - 42 pin Ceramic Frit-seal DIP, with window (0.370" x 0.450").	)j. TC
	FDIP42W - 42 pin Ceramic Frit-seal DIP, with window (0.370" x 0.450"), package mechanical data	19
Table 13.	PDIP42 - 42 pin Plastic DIP, 600 mils width, package mechanical data	20
Table 14.	SDIP42 - 42 pin Shrink Plastic DIP, 600 mils width, package mechanical data	21
Table 15.	Ordering information scheme	2.1.22
Table 16.	Document revision history	23
	16,	
	60,000	
	16) -010	
	3/13/	
	PDIP42 - 42 pin Plastic DIP, 600 mils width, package mechanical data SDIP42 - 42 pin Shrink Plastic DIP, 600 mils width, package mechanical data Ordering information scheme	
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List of figures M27C322

# List of figures

Figure 1. Figure 2. Figure 3. Figure 4. Figure 5. Figure 6. Figure 7. Figure 8. Figure 9.	Logic Diagram.  DIP Connections.  Programming Flowchart  AC Testing Input Output Waveform  AC Testing Load Circuit  Read Mode AC Waveforms  MARGIN MODE AC Waveforms.  Programming and Verify Modes AC Waveforms  FDIP42W - 42 pin Ceramic Frit-seal DIP, with window (0.370" x 0.450"),
Figure 10.	package outline
Figure 11.	
Obsoli Obsoli	SDIP42 - 42 pin Shrink Plastic DIP, 600 mils width, package outline

## 1 Summary description

The M27C322 is a 32 Mbit EPROM offered in the UV range (ultra violet erase). It is ideally suited for microprocessor systems requiring large data or program storage. It is organised as 2 MWords of 16 bit. The pin-out is compatible with a 32 Mbit Mask ROM.

The FDIP42W (window ceramic frit-seal package) has a transparent lid which allows the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written rapidly to the device by following the programming procedure.

For applications where the content is programmed only one time and erasure is not required, the M27C322 is offered in PDIP42 and SDIP42 packages.

In order to meet environmental requirements, ST offers the M27C322 in ECOPACK® packages.

ECOPACK packages are Lead-free. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked and the inner box label.

ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

Figure 1. Logic Diagram

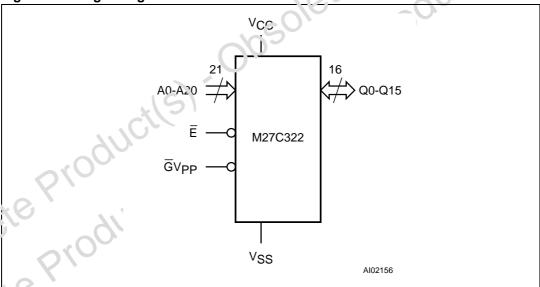
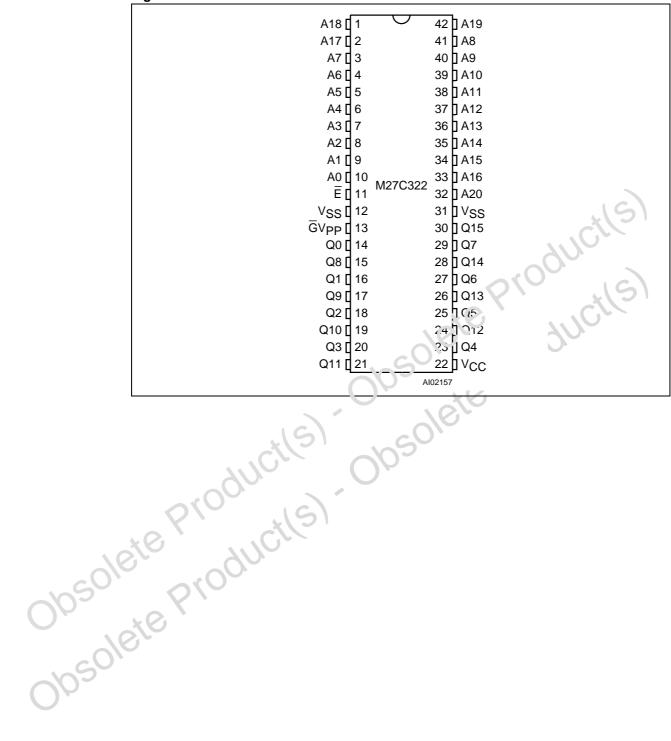


Table 1. Signal Names

A0-A20	Address Inputs
Q0-Q15	Data Outputs
Ē	Chip Enable
ŪV <sub>PP</sub>	Output Enable / Program Supply
V <sub>CC</sub>	Supply Voltage
V <sub>SS</sub>	Ground

Figure 2. DIP Connections



M27C322 Device operation

## 2 Device operation

The operating modes of the M27C322 are listed in the Operating Modes Table. A single power supply is required in the read mode. All inputs are TTL compatible except for  $V_{PP}$  and 12V on A9 for the Electronic Signature.

#### 2.1 Read mode

The M27C322 has a word-wide organization. Chip Enable  $(\overline{E})$  is the power control and should be used for device selection. Output Enable  $(\overline{G})$  is the output control and should be used to gate data to the output pins independent of device selection. Assuming that the addresses are stable, the address access time  $(t_{AVQV})$  is equal to the delay from  $\overline{E}$  to output  $(t_{ELQV})$ . Data is available at the output after a delay of  $t_{GLQV}$  from the falling edge of  $\overline{GV_{PR}}$  assuming that  $\overline{E}$  has been low and the addresses have been stable for at least  $t_{AVQV}$   $t_{GLQV}$ .

#### 2.2 Standby mode

The M27C322 has a standby mode which reduces the supplying a CMOS high signal to the  $\overline{E}$  input. When in the standby mode, the outputs are in a night impedance state, independent of the  $\overline{GV}_{PP}$  input.

### 2.3 Two line output control

Because EPROMs are caused in larger memory arrays, this product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allow:

- 1. the low(:s) possible memory power dissipation,
- 2. complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines,  $\overline{E}$  should be decoded and used as the pulmary device selecting function, while  $\overline{GV_{PP}}$  should be made a common connection to all devices in the array and connected to the  $\overline{READ}$  line from the system control bus. This ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

Device operation M27C322

### 2.4 System Considerations

The power switching characteristics of Advanced CMOS EPROMs require careful decoupling of the supplies to the devices. The supply current ICC has three segments of importance to the system designer: the standby current, the active current and the transient peaks that are produced by the falling and rising edges of  $\overline{E}$ . The magnitude of the transient current peaks is dependent on the capacitive and inductive loading of the device outputs. The associated transient voltage peaks can be suppressed by complying with the two line output control and by properly selected decoupling capacitors. It is recommended that a 0.1  $\mu$ F ceramic capacitor is used on every device between  $V_{CC}$  and  $V_{SS}$ . This should be a high frequency type of low inherent inductance and should be placed as close as possible to the device. In addition, a 4.7  $\mu$ F electrolytic capacitor should be used between  $V_{CC}$  and  $V_{SS}$  for every eight devices. This capacitor should be mounted near the power supply connection point. The purpose of this capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

## 2.5 Programming

When delivered (and after each erasure for UV EPROM), all Lits or the M27C322 are in the "1" state. Data is introduced by selectively programming "o's into the desired bit locations. Although only "0"s will be programmed, both "1"s and "0"s can be present in the data word. The only way to change a "0" to a "1" is by die exposition to ultraviolet light (UV EPROM). The M27C322 is in the programming mode where  $V_{PP}$  input is at 12.V,  $\overline{G}V_{PP}$  is at  $V_{IH}$  and  $\overline{E}$  is pulsed to  $V_{IL}$ . The data to be programming is applied to 16 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.  $V_{CC}$  is specified to be 6.25V  $\pm$  0.25V.

## 2.6 PRESTO III Programming Algorithm

The PRESTO III Programming Algorithm allows the whole array to be programed with a guaranteer that gin in a typical time of 100 seconds. Programming with PRESTO III consists of appiving a sequence of 50µs program pulses to each word until a correct verify occurs (soe Figure 3). During programing and verify operation a MARGIN MODE circuit must be activated to guarantee that each cell is programed with enough margin. No overprogram pulse is applied since the verify in MARGIN MODE provides the necessary margin to each programmed cell.

M27C322 Device operation

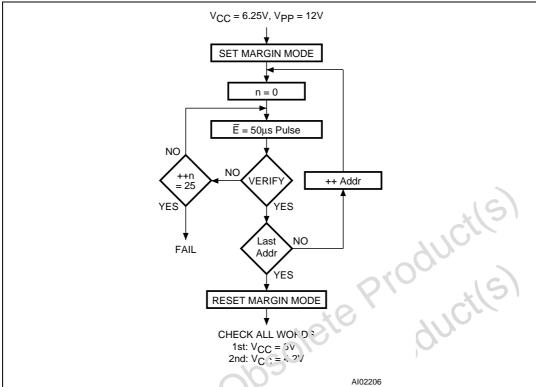


Figure 3. Programming Flowchart

## 2.7 Program Inhibit

Programming of multiple M27C322s in parallel with different data is also easily accomplished. Except for  $\overline{E}$ , all like inputs including  $\overline{GV_{PP}}$  of the parallel M27C322 may be common. A Third well-bulse applied to a M27C322's  $\overline{E}$  input and  $V_{PP}$  at 12V, will program but w27C322. A high level  $\overline{E}$  input inhibits the other M27C322s from being programmed.

## 2.8 Program Verify

A verify (read) should be performed on the programmed bits to determine that they were correctly programmed. The verify is accomplished with  $\overline{G}V_{PP}$  at  $V_{IL}$ . Data should be verified with  $t_{ELQV}$  after the falling edge of  $\overline{E}$ .

Device operation M27C322

#### 2.9 Electronic Signature

The Electronic Signature (ES) mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. The ES mode is functional in the 25°C  $\pm$  5°C ambient temperature range that is required when programming the M27C322. To activate the ES mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27C322, with  $V_{PP} = V_{CC} = 5V$ . Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from  $V_{IL}$  to  $V_{IH}$ . All other address lines must be held at  $V_{II}$  during Electronic Signature mode.

Byte 0 (A0 =  $V_{IL}$ ) represents the manufacturer code and byte 1 (A0 =  $V_{IH}$ ) the device identifier code. For the STMicroelectronics M27C322, these two identifier bytes are given in *Table 3.* and can be read-out on outputs Q0 to Q7.

## 2.10 Erasure operation (applies to UV EPROM)

The erasure characteristics of the M27C322 is such that eracure begins when the cells are exposed to light with wavelengths shorter than approximately 2000 Å. It should be noted that sunlight and some type of fluorescent lamps have we veriengths in the 3000-4000 Å range. Research shows that constant exposure to receive level fluorescent lighting could erase a typical M27C322 in about 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sonting. If the M27C322 is to be exposed to these types of lighting conditions for extended the review of time, it is suggested that opaque labels be put over the M27C322 window to prevent unintentional erasure. The recommended erasure procedure for M27C322 is exposure to short wave ultraviolet light which has a wavelength of 2537 Å. The long rated dose (i.e. UV intensity x exposure time) for erasure should be a minimum of 30 Vv-sec/cm². The erasure time with this dosage is approximately 30 to 40 minutes using an ultraviolet lamp with 12000 µW/cm² power rating. The M27C322 should be placed within 2.5cm (1 inch) of the lamp tubes during the erasure. Some lamps have a filter on their tubes which should be removed before erasure.

M27C322 **Device operation** 

Operating Modes<sup>(1)</sup> Table 2.

- opening means							
Mode	Ē	<b>G</b> V <sub>PP</sub>	А9	Q15-Q0			
Read	V <sub>IL</sub>	V <sub>IL</sub>	Х	Data Out			
Output Disable	V <sub>IL</sub>	V <sub>IH</sub>	Х	Hi-Z			
Program	V <sub>IL</sub> Pulse	V <sub>PP</sub>	Х	Data In			
Program Inhibit	V <sub>IH</sub>	V <sub>PP</sub>	X	Hi-Z			
Standby	V <sub>IH</sub>	X	X	Hi-Z			
Electronic Signature	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>ID</sub>	Codes			

<sup>1.</sup>  $X = V_{IH}$  or  $V_{IL}$ ,  $V_{ID} = 12V \pm 0.5V$ .

Electronic Signature<sup>(1)</sup> Table 3.

lo
Manuf Code
Device
ete

M27C322 Maximum rating

#### 3 **Maximum rating**

Stressing the device above the rating listed in the Absolute Maximum Ratings table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

**Absolute Maximum Ratings** Table 4.

Symbol	Parameter	Value	Unit
T <sub>A</sub>	Ambient Operating Temperature <sup>(1)</sup>	-40 to 125	C)°
T <sub>BIAS</sub>	Temperature Under Bias	-50 to 125	°C
T <sub>STG</sub>	Storage Temperature	-60 to 150	°C
V <sub>IO</sub> <sup>(2)</sup>	Input or Output Voltage (except A9)	-2 to 7	V
V <sub>CC</sub>	Supply Voltage	–2 to 7	V
V <sub>A9</sub> <sup>(2)</sup>	A9 Voltage	-2 to 13.5	V
V <sub>PP</sub>	Program Supply Voltage	-2 to 14	V

<sup>1.</sup> Depends on range.

at is =0.5 / with pt ...put is V<sub>2</sub> ±9.5V with Minimum DC voltage on Input or Output is -0.5 / % h possible undershoot to -2.0V for a period less than 20ns. Maximum DC voltage on Output is  $V_{CC}$  +7.5V with possible overshoot to  $V_{CC}$  +2V for a period less

## 4 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC Characteristic tables that follow are derived from tests performed under the Measurement Conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 5. AC Measurement Conditions

	High Speed	Standard
Input Rise and Fall Times	≤10ns	⊴20ns
Input Pulse Voltages	0 to 3V	0.4V to 2.4V
Input and Output Timing Ref. Voltages	1.5V	0 8V and 2V

Figure 4. AC Testing Input Output Waveform

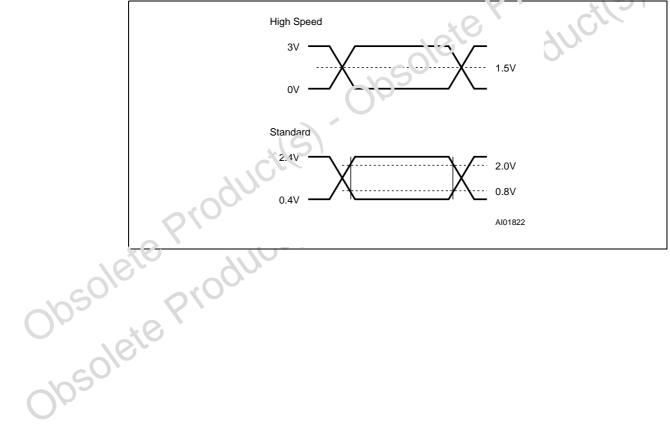
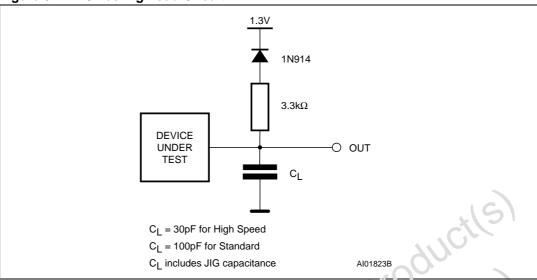


Figure 5. **AC Testing Load Circuit** 



Capacitance  $(T_A = 25 \, ^{\circ}C, f = 1 \, MHz)^{(1)}$ Table 6.

Symbol	Parameter	Test Condition	Min	Max	Uni
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	- *(	10	pF
C <sub>OUT</sub>	Output Capacitance	'v <sub>O</sub>	61	12	pF
	1.1Gr	Uh			
etePr	ancile)				
ete Properties	oduct(s)				

Read Mode DC Characteristics (1)(2) Table 7.

Symbol	Parameter	Test Condition	Min	Max	Unit
I <sub>LI</sub>	Input Leakage Current	0v ≤V <sub>IN</sub> ≤V <sub>CC</sub>		±1	μΑ
I <sub>LO</sub>	Output Leakage Current	0V ≤V <sub>OUT</sub> ≤V <sub>CC</sub>		±10	μA
	Supply Current	$\overline{E} = V_{IL}, \overline{G}V_{PP} = V_{IL}, I_{OUT} = 0mA,$ f = 8MHz		70	mA
Icc	зарру Сипен	$\overline{E} = V_{IL}, \overline{G}V_{PP} = V_{IL}, I_{OUT} = 0mA,$ f = 5MHz		50	mA
I <sub>CC</sub> 1	Supply Current (Standby) TTL	E = V <sub>IH</sub>		1	mA
I <sub>CC</sub> 2	Supply Current (Standby) CMOS	Ē > V <sub>CC</sub> − 0.2V		100	μA
I <sub>PP</sub>	Program Current	$V_{PP} = V_{CC}$	. (	10	μA
V <sub>IL</sub>	Input Low Voltage		-7.3	0.8	V
V <sub>IH</sub> <sup>(3)</sup>	Input High Voltage	O10	2	V <sub>CC</sub> + 1	V
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output High Voltage TTL	I <sub>OH</sub> = -10 γμ/γ.	2.4		٧

- 1.  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and  $r_c$  moved simultaneously or after  $V_{PP}$ .
- 2.  $(T_A = 0 \text{ to } 70 \text{ °C}, -40 \text{ to } 85 \text{ °C or } -40 \text{ to } 125 \text{ °C}; V_{CC} 5 \text{ V} 10\%; V_{PP} = V_{CC})$
- 3. Maximum DC voltage on Output is  $V_{CC}$  +0.5 $^{\circ}$ .

Programming Mode DC Characteristics(1)(2) Table 8.

	Symbol	Parameter	Test Condition	Min	Max	Unit
	I <sub>LI</sub>	Input Leakage Current	V <sub>IL</sub> ≤V <sub>IN</sub> ≤V <sub>IH</sub>		±10	μΑ
	I <sub>CC</sub>	Supply Curi and	O <sup>v</sup>		50	mA
	I <sub>PP</sub>	Program Current	$\overline{E} = V_{IL}$		50	mA
	V <sub>IL</sub>	Input Low Voltage		-0.3	0.8	V
10	V <sub>IH</sub>	Input High Voltage		2.4	V <sub>CC</sub> + 0.5	V
601,	V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1mA		0.4	V
002	V <sub>OH</sub>	Output High Voltage TTL	I <sub>OH</sub> = -2.5mA	3.5		V
0.	$V_{ID}$	A9 Voltage		11.5	12.5	V
absolf		°C; $V_{CC} = 6.25V \pm 0.25V$ ; $V_{PP} = 12$ ast be applied simultaneously with o		multaneously	or after V <sub>PP</sub> .	

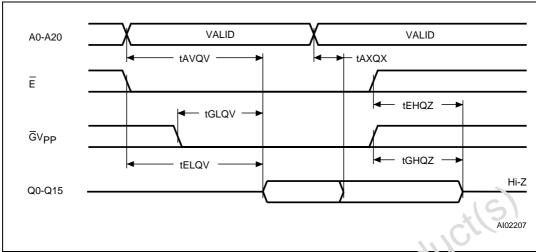


Figure 6. **Read Mode AC Waveforms** 

Read Mode AC Characteristics<sup>(1)</sup> (2) Table 9.

						M27	C322	12	1
	Symbol	Alt	Parameter	Test Condition	-80 <sup>(3)</sup>		<u> </u>	00	Unit
				3010	Min	Max	Min	Max	
	t <sub>AVQV</sub>	t <sub>ACC</sub>	Address Valid to Output vaio	$\bar{E} = V_{IL},  \overline{G}V_{PP} = V_{IL}$	À	80		100	ns
	t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable Low to Output Valid	$\overline{G}V_{PP} = V_{IL}$		80		100	ns
	t <sub>GLQV</sub>	t <sub>OE</sub>	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		40		50	ns
	t <sub>EHQZ</sub> <sup>(4)</sup>	t <sub>D</sub> r	Chip Enable High to Output Hi-Z	$\overline{G}V_{PP} = V_{IL}$	0	40	0	40	ns
	t <sub>GHQZ</sub> (1)	t <sub>DF</sub>	Output Enable High to Output Hi-Z	E = V <sub>IL</sub>	0	40	0	40	ns
9/6	TAXQX	t <sub>OH</sub>	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G}V_{PP} = V_{IL}$	5		5		ns
0.	<ol> <li>V<sub>CC</sub> mu</li> <li>Speed of</li> </ol>	st be apobtained	C, –40 to 85 °C or –40 to 125 °C; V <sub>C</sub> pplied simultaneously with or before d with High Speed AC measurement not 100% tested.	V <sub>PP</sub> and removed simul		sly or a	fter V <sub>Pl</sub>	<b>-</b>	

- 1.  $(T_A = 0 \text{ to } 70 \text{ °C}, -40 \text{ to } 85 \text{ °C or } -40 \text{ to } 125 \text{ °C}; V_{CC} = 5V \pm 10\%; V_{PP} = V_{CC})$
- 2.  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$  3. Speed obtained with High Speed AC measurement conditions.
- Sampled only, not 100% tested.

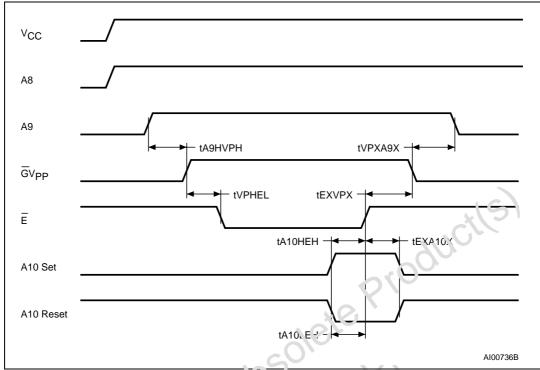


Figure 7. **MARGIN MODE AC Waveforms** 

1. A8 High level = 5V; A9 High level = 12V.

MARGIN MODE AC Characteristics<sup>(1)</sup> (2) Table 10.

	Symbol	Alt	Parameter	Test Condition	Min	Max	Unit
	t <sub>A9HVPH</sub>	t <sub>AS</sub> o	V <sub>A'</sub> , High to V <sub>PP</sub> High		2		μs
	t <sub>VPHEI</sub>	VP3	V <sub>PP</sub> High to Chip Enable Low		2		μs
	t <sub>A10HE</sub> +	<sup>(</sup> AS10	V <sub>A10</sub> High to Chip Enable High (Set)		1		μs
16	t <sub>A10LEH</sub>	t <sub>AS10</sub>	V <sub>A10</sub> Low to Chip Enable High (Reset)		1		μs
50,	t <sub>EXA10X</sub>	t <sub>AH10</sub>	Chip Enable Transition to V <sub>A10</sub> Transition		1		μs
\	t <sub>EXVPX</sub>	t <sub>VPH</sub>	Chip Enable Transition to V <sub>PP</sub> Transition		2		μs
	t <sub>VPXA9X</sub>	t <sub>AH9</sub>	V <sub>PP</sub> Transition to V <sub>A9</sub> Transition		2		μs
2000			$6.25V \pm 0.25V$ ; $V_{PP} = 12V \pm 0.25V$ ) ed simultaneously with or before $V_{PP}$ and re	emoved simultane	eously or af	ter V <sub>PP</sub> .	

<sup>1.</sup>  $T_A = 25$  °C;  $V_{CC} = 6.25V \pm 0.25V$ ;  $V_{PP} = 12V \pm 0.25V$ )

<sup>2.</sup>  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .

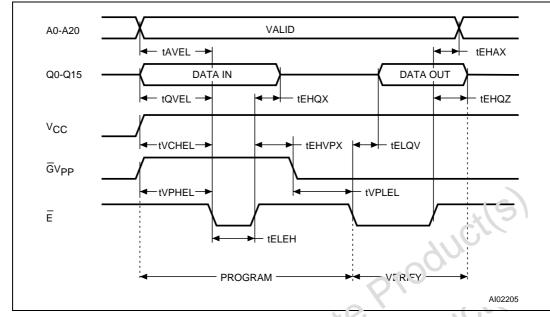


Figure 8. **Programming and Verify Modes AC Waveforms** 

1.  $\overline{G}V_{PP}$  High level = 12V.

Programming Mode AC Characteristics (1) (2) Table 11.

	Symbol	Alt	Paramer 3.	Test Condition	Min	Max	Unit
	t <sub>AVEL</sub>	t <sub>AS</sub>	Address Valid to Chip Enable Low		1		μs
	t <sub>QVEL</sub>	t <sub>DS</sub>	Input Valid to Chip Enable Low		1		μs
	t <sub>VCHEL</sub>	t <sub>VCS</sub>	V <sub>C</sub> . High to Chip Enable Low		2		μs
	t <sub>VPHEL</sub>	t <sub>∩E</sub> 3	v <sub>PP</sub> High to Chip Enable Low		1		μs
	t <sub>VPLV</sub> PH	rh41	V <sub>PP</sub> Rise Time		50		ns
	(CLEH	t <sub>PW</sub>	Chip Enable Program Pulse Width (Initial)		45	55	μs
	t <sub>EHQX</sub>	t <sub>DH</sub>	Chip Enable High to Input Transition		2		μs
-1050	t <sub>EHVPX</sub>	t <sub>OEH</sub>	Chip Enable High to V <sub>PP</sub> Transition		2		μs
Ob.	t <sub>VPLEL</sub>	t <sub>VR</sub>	V <sub>PP</sub> Low to Chip Enable Low		1		μs
\( \( \)	t <sub>ELQV</sub>	t <sub>DV</sub>	Chip Enable Low to Output Valid			1	μs
c0//	t <sub>EHQZ</sub> (3)	t <sub>DFP</sub>	Chip Enable High to Output Hi-Z		0	130	ns
0/02	t <sub>EHAX</sub>	t <sub>AH</sub>	Chip Enable High to Address Transition		0		ns
O	,,		$6.25V \pm 0.25V$ ; $V_{PP} = 12V \pm 0.25V$ )  d simultaneously with or before $V_{PP}$ and remove	ed simultaneousl	v or after	Von	

<sup>1.</sup>  $T_A = 25$  °C;  $V_{CC} = 6.25V \pm 0.25V$ ;  $V_{PP} = 12V \pm 0.25V$ )

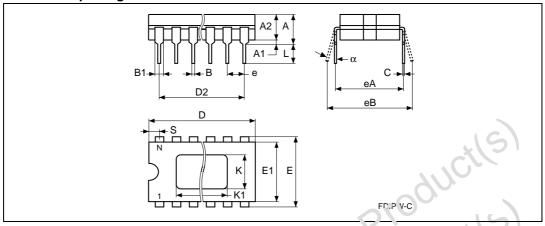
<sup>2.</sup>  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .

<sup>3.</sup> Sampled only, not 100% tested.

M27C322 Package mechanical

# 5 Package mechanical

Figure 9. FDIP42W - 42 pin Ceramic Frit-seal DIP, with window (0.370" x 0.450"), package outline



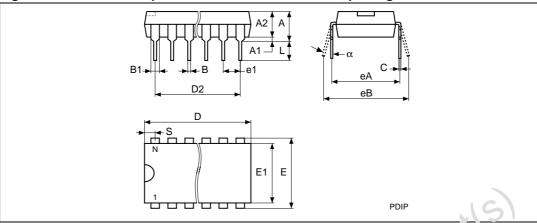
1. Drawing is not to scale.

Table 12. FDIP42W - 42 pin Ceramic Frit-seal ΓιΡ, with window (0.370" x 0.450"), package mechanical data

		millimeters	105	0	inches	
Symbol -	Тур	Min	Max	Тур	Min	Max
А			5.71	O		0.225
A1		0.50	1.78		0.020	0.070
A2	1110	3.90	5.08		0.154	0.200
В	70,0	0.40	0.55		0.016	0.022
Pı	, ,	1.27	1.52		0.050	0.060
С	· C	0.22	0.31		0.009	0.012
D	AUI		54.81			2.158
D2	50.80	_	_	2.000	-	_
E	15.24			0.600		
E1		14.50	14.90		0.571	0.587
е		2.29	2.79		0.090	0.110
eA		15.40	15.80		0.606	0.622
eB		16.17	18.32		0.637	0.721
K		9.32	9.47		0.367	0.373
K1		11.30	11.55		0.445	0.455
L		3.18	4.10		0.125	0.161
S	·	1.52	2.49		0.060	0.098
α		4°	15°		4°	15°
N		42			42	

Package mechanical M27C322

Figure 10. PDIP42 - 42 pin Plastic DIP, 600 mils width, package outline



1. Drawing is not to scale.

Table 13. PDIP42 - 42 pin Plastic DIP, 600 mils width, package niechanical data

	Cumbal		millimeters		O,	inches	115)
	Symbol	Тур	Min	Max	Γγη	Min	Max
	Α		_	5.08	S.	$\bigcirc$	0.200
	A1		0.25	5	0	0.010	_
	A2		3.56	7.06		0.140	0.160
	В		0.38	0.53	0,10	0.015	0.021
	B1		1.27	1.65		0.050	0.065
	С	, C	0.20	0.36		0.008	0.014
	D	YU	52.20	52.71		2.055	2.075
	D2	08.0c		_	2.000	_	_
	E	15.24	(2)	_	0.600	_	_
	E1	1,10	13.59	13.84		0.535	0.545
	e1	2.54	_	_	0.100	-	_
	eA	14.99	_	_	0.590	_	_
	еВ		15.24	17.78		0.600	0.700
10	L		3.18	3.43		0.125	0.135
0/	S		0.86	1.37		0.034	0.054
9	α		0°	10°		0°	10°
	N		42			42	

M27C322 Package mechanical

Figure 11. SDIP42 - 42 pin Shrink Plastic DIP, 600 mils width, package outline

1. Drawing is not to scale.

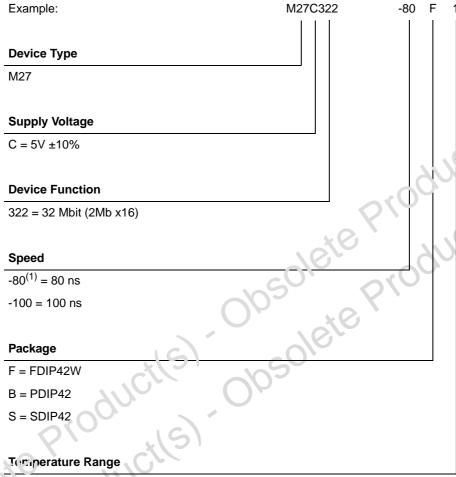
Table 14. SDIP42 - 42 pin Shrink Plastic DIP, 600 mils width, package mechanical data

	Cumhal		millimeters		× 0,	inches	
	Symbol	Тур	Min	Max	Гур	Min	Max
	Α			5.08	0	(0)	0.200
	A1		0.51	70.	. 0. 1	0.020	
	A2	3.81	3.05	4.57	0.150	0.120	0.180
	b	0.46	0.38	0.56	0.018	0.015	0.022
	b2	1.02	0.89	1.14	0.040	0.035	0.045
	С	0.25	0.23	0.38	0.010	0.009	0.015
	D	36.83	36.58	37.08	1.450	1.440	1.460
	E	1.78	(2)	-	0.070	_	_
*	SE	1,10	15.24	16.00		0.600	0.630
	E1	13.72	12.70	14.48	0.540	0.500	0.570
)	eA	15.24	-	-	0.600	-	_
	еВ			18.54			0.730
10:	L	3.30	2.54	3.56	0.130	0.100	0.140
2//	S	0.63			0.025		
	N		42			42	

Part numbering M27C322

# 6 Part numbering

Table 15. Ordering information scheme



1 = 0 to 70 °C

3 = -40 to 125 °C

 $6 = -40 \text{ to } 85 \,^{\circ}\text{C}$ 

1. High Speed, see AC Characteristics section for further information.

For a list of available options (Speed, Package, etc...) or for further information on any aspect of this device, please contact the STMicroelectronics Sales Office nearest to you.

M27C322 Revision history

# 7 Revision history

Table 16. Document revision history

July 1999
53., 1555
24-Feb-2000
04-Apr-2000
20-Sep-2000
29-Nov-2000
27-Feb-2001
27-Nov-2003
28-Mar-2006
ie Pro

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